

**Search Notes**

Application/Control No.

10/526,223

Examiner

Louis K. Huynh

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

3721

**SEARCHED**

Class	Subclass	Date	Examiner
53	403 472 139.5	5/18/2007	/LH/
206	521 522	5/18/2007	/LH/
383	3	5/18/2007	/LH/
Updated	All above	1/22/2008	LH
Updated	All above	4/29/2008	LH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>53, 206</b>	<b>All above</b>	4/29/2008	<b>LH</b>
383	3	4/29/2008	LH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search in US-PAT & US-PGPUB databases - See printout	4/29/2008	LH